Determining Domain of Machine Learning Models using Kernel Density Estimates: Applications in Materials Property Prediction

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Abstract

Knowledge of the domain of applicability of a machine learning model is essential to ensuring accurate and reliable model predictions. In this work, we develop a new approach of assessing model domain and demonstrate that our approach provides accurate and meaningful designation of in-domain versus out-of-domain when applied across multiple model types and material property data sets. Our approach assesses the distance between a test and training data point in feature space by using kernel density estimation and shows that this distance provides an effective tool for domain determination. We show that chemical groups considered unrelated based on established chemical knowledge exhibit significant dissimilarities by our measure. We also show that high measures of dissimilarity are associated with poor model performance (i.e., high residual magnitudes) and poor estimates of model uncertainty (i.e., unreliable uncertainty estimation). Automated tools are provided to enable researchers to establish acceptable dissimilarity thresholds to identify whether new predictions of their own machine learning models are in-domain versus out-of-domain.

Keywords: Chemistry, Machine learning, Domain, Uncertainty Quantification, Materials Science

1 Introduction

Machine learning (ML), as one component of the larger umbrella of artificial intelligence (AI), is one of the fastest evolving technologies in the world today. In the context of materials science, thousands of papers using ML are now published each year, and the number of publications using ML has been growing exponentially since around 2015 [1, 2]. The applications of ML in materials science takes many forms, including materials property prediction [3], computer vision-based defect detection and microstructure segmentation [4, 5], assimilation of data and knowledge from publications using natural language processing and large language models [6, 7], and fitting of ML-based interatomic potentials representing nearly all elements in the periodic table to enable fast and accurate atomistic simulations [8]. Useful ML models generally require some form of prediction quality quantification because models can experience significant performance degradation when predicting on data that falls outside the model's domain of applicability. This performance degradation can manifest as high errors, unreliable uncertainty estimates, or both. Without some estimation of model domain, one does not know, a priori, whether the results are reliable when making predictions on new test data. More precisely, useful ML models ideally have at least the following three characteristics regarding their prediction quality: (i) accurate prediction, meaning the model has low residual magnitudes, (ii) accurate uncertainty in prediction, meaning the model produces some useful quantification of uncertainty on new predictions (note this requirement does not stipulate that the uncertainties should be small), and (iii) domain classification, meaning the model can reliably determine when predictions are inside a domain (ID) versus outside a domain (OD) of feature space where the model is trustworthy.

Separate from determining whether data are ID or OD are the techniques used in domain adaptation. In certain situations, domain adaptation techniques enable the fine-tuning of a model or data to transform originally OD data into ID data. The objective of domain adaptation is to adapt a model for prediction on a property (denoted as M^{prop} here) to new data whose distribution may be shifted from training data [9, 10]. The task of domain adaptation is distinct from the focus of this paper, which is focused on identifying when data are likely to be OD. There would be no need to identify OD data if domain adaptation were always effective, but adapting models to initially OD data can be a challenging and intricate process. First, many techniques require re-training models, involving a substantial effort in tuning parameters and validating models. Second, once a model is adapted to one target domain, it may still fail on other unknown domains. It is therefore useful to have a method to identify when a model is applied to problematic domains without having to adapt the model. In this work, we develop a domain classification technique that identifies when predictions are likely ID or OD (equivalently ID/OD).

The domain classification problem, at least for materials property prediction and many other similar problems, can be formulated as follows: given a trained model M^{prop} and the features of an arbitrary test data point, how can we develop a model to predict if the test data point is ID/OD for M^{prop} ? In this work, we frame this challenge as a classic supervised ML problem for categorization. To develop such a model, we need training data with input features and labels, which labels are ID and OD, as well as some ML modeling approach for making the prediction ID/OD. We will denote this ML model for domain as M^{dom} to distinguish it from M^{prop} . Note that the labeled training data for M^{dom} does not necessarily have to match the original M^{prop} model training data.

There is no unique, universal definition for the domain of an M^{prop} model, and therefore no unambiguously defined labels for the M^{dom} training data. In other words, we do not have an absolute ground truth labeling on which to train the M^{dom} model [11, 12]. This problem can be solved by imposing some reasonable definition of ground truth for ID/OD based on model reliability, as quantified by, e.g., small residual magnitudes and stable predictions under changes in data. In many cases ID/OD data points are described in terms of a region of feature space, in which case M^{dom} becomes a trivial check if a data point is in the region or not [13]. Predictions of ID/OD are often checked against chemical intuition of whether data is somehow "similar" to training data, and therefore ID, or not, and therefore OD. Such checks are an effective way of using field-specific knowledge of similarity to provide a ground truth for ID/OD classification.

Two sophisticated approaches have been developed in Refs. [14, 15] that effectively find a region in feature space where an M^{prop} model shows performance above some cutoff. These approaches are potentially very powerful but have limitations. For methods that create a single connected region to denote as ID, multiple disjointed regions in space that could yield perfectly reasonable predictions from M^{prop} will be excluded because of the requirement of one continuous space. A method by which non-connected ID regions are established without a single, pre-defined shape would be advantageous (e.g., with kernel density estimation, as done in this work). In addition, the sophisticated approaches in these models introduce significant complexity, which makes them challenging to implement. It is therefore useful to revisit simpler approaches that build directly on the intuition that ID regions of feature space are likely to be those regions close to significant amounts of training data [16–18]. In this work, we show that such an approach based on kernel density estimates can provide a simple and effective method for classifying data as ID/OD with no restrictions on the shape of the ID region.

There are many techniques for quantifying closeness in feature spaces, including convex hulls, distance measures, and (probability) density estimates [13]. While identifying as ID all data within a convex hull of the training data methods is reasonable, such approaches have the major limitation of potentially including large regions with no training data. For example, the convex hull of points on a circle in a two-dimensional feature space includes the entirely empty middle of the circle as ID. Distance measures are also a reasonable approach to measure closeness. In Ref. [19], distance measures from a number of nearest neighbors was used as a dissimilarity score between a point and a model's training data. They showed that target property prediction errors generally increase with increasing distance, which followed intuition. Nevertheless, distance measures have the limitation of there being no unique measure of distance between two points and no unique single distance of a new point from a set of training data. This creates a vast space of possible ways of measuring two-point distances (e.g., Euclidean, Mahalanobis, etc.) and one to N-point distances (closest point distance, closest k-points distance, weighted average of distances, etc.), making it difficult to find a robust method. In general, approaches based on convex hulls or standard distances between points do not account naturally for data sparsity, and may consider a point near one training data point or many training data points as almost identically likely to be ID. We therefore focus on probability measures, as they provide a natural solution to all the issues around topology, distance measures, and data sparsity just mentioned above.

We quantified the density of training data features in feature space through kernel density estimates (KDE), which allowed us to estimate the likelihood (estimate of the underlying probability density for an observation) of observing a test case from a numerically constructed probability density function (PDF). KDE, and density-based methods in general, offer several advantages vs. other approaches, including (i) a density value that can act as a distance or dissimilarity measure, (ii) a natural accounting for data sparsity, and (iii) trivial treatment of arbitrarily complex geometries of data and *ID* regions. Similarly, techniques utilizing Gaussian process have comparable advantages. But unlike Gaussian process, KDE is relatively fast to fit and evaluate, at least of modest size data sets that are common in materials (see Supplemental Materials for comparisons between KDE and Gaussian process regression). We will evaluate the ability of KDE likelihoods to classify *ID/OD* cases given several reasonable ground truth definitions of domain that include chemical intuitions, residuals, and error in predicted uncertainties.

To determine if KDE can be used to define ID regions, we must set a ground truth for ID for training and assessment. Given the absence of any unique ground truth, as noted above, we explore four different approaches. Specifically, we define four domain types, each based on a corresponding ground truth, which are: (i) a chemical domain where test data materials with similar chemical characteristics to the training data are ID, (ii) a residual domain where test data with residuals below a chosen threshold are ID, (iii) another residual domain where groups (i.e., not single cases) of test data with residuals below a chosen threshold are ID, and (iv) an uncertainty domain where groups of test data with differences between predicted and expected uncertainties below a chosen threshold are *ID*. See Sec. 2.3 for more detailed definitions. For each of our four domain types, we assessed our models on sets of test data that were increasingly distinct from the training data. Generally, test cases that had high KDE likelihoods were chemically similar, had low residuals, and had accurate uncertainties, just as one would hope for an effective method of domain determination.

Here we summarize the structure of the paper. Sec. 2 has some basic details on software (Sec. 2.1), ML models (Sec. 2.2), our definitions of domain (Sec. 2.3), the methodology behind assessing domains (Sec. 2.4), and our five data sets with details on their featurization and chemical properties (Sec. 2.5). Four materials property data sets and one commonly used synthetic data set were studied. Various model types including random forest, bagged support vector regressor, bagged neural network, and bagged ordinary least squares models were trained with the aforementioned data sets. We then show the assessment of our domain predictions in Sec. 3. We finish with conclusions (Sec. 4), data and code resources (Sec. 5), and acknowl-edgements (Sec. 6). Our findings indicate that KDE likelihoods can provide valuable insights of model applicability domain, enabling effective classification of ID/OD for most data sets and models examined here. Importantly, our approach is expected to be generally applicable to regression-based prediction problems involving tabular data and can be easily applied to other regression tasks.

2 Methods

2.1 Software Tools Used

In our study, we utilized different software tools for analysis. We employed the Materials Simulation Toolkit for Machine Learning (MAST-ML) to generate and select features, X, across multiple data sets [20]. Furthermore, we utilized various models and subroutines from scikitlearn [21]. For neural network (NN) implementations, we relied on Keras [22]. Visualization from projecting X onto lower dimensions used the Uniform Manifold Approximation and Projection (UMAP) package [23].

2.2 Definition of Model Types

We outline here the types of models and their applications in this work, defining nomenclature for each. First, M^{prop} is a regression model that uses X to predict a property, y. Second, M^{dom} is a classification model that predicts domain labels ID/OD given X. The predicted labels of domain will henceforth be called \widehat{ID} and \widehat{OD} . Construction of M^{dom} requires other additional models. We define a model called $M^{dis}(X,\vec{x})$ (or just M^{dis} for short) which returns a dissimilarity score between a data point \vec{x} and the data X used in training M^{prop} . Details of the construction of M^{dis} are covered in Sec. 2.2.3. Finally, we also build a model for predicting uncertainties in M^{prop} predictions, M^{unc} , which uses M^{prop} as outlined in Sec. 2.2.2. The data used to build or train the models of M^{prop} , M^{unc} , and M^{dis} will be referred to as In-The-Bag (ITB). Conversely, the data excluded from the training of these models will be termed Out-Of-Bag (OOB). The following subsections provide explanations for how M^{prop} , M^{unc} , and M^{dis} combine to generate M^{dom} . Because of the interdependence of many kinds of models to produce M^{dom} , a summary of models, their inputs, and their outputs are provided in Table 1.

Model	Description	Training Inputs	Deployment Inputs	Outputs
M^{prop}	Property prediction	$X, \{y\}$	$ec{x}$	\hat{y}, σ_u
M^{unc}	Uncertainty estimation	$\{y, \hat{y}, \sigma_u\}$	σ_u	σ_c
M^{dis}	Measuring dissimilarity	X	$ec{x}$	d
M^{dom}	Classifying domain	$\{d, ID/OD\}$	d	$\widehat{ID}/\widehat{OD}$

Table 1: Summary of the variables used in model training, the variables used in model prediction, and the outputs from each model covered. $\{\cdot\}$ represents a set.

In some cases, these models are very simple, e.g., just a simple function or a check if a value is above or below a cutoff. We make the choice of defining them as models and denoting them with a variable for two reasons. First, it gives a well-defined symbol for each item, which makes the discussion more precise and compact, although at the cost of more variables. Second, defining each of these relationships as models stresses the fact that the specific models we use in this work could easily be replaced by other models, and these could be much more complex. For example, our domain model M^{dom} for predicting whether a test data point with features \vec{x} belongs to the ID domain is a simple check of whether the kernel density value exceeds a cutoff. However, this could be replaced by a more complex ML model based on the KDE or other features. We hope that these definitions will help make the paper clearer and suggest natural ways to improve our approach in the future.

2.2.1 Model for Property Regression (M^{prop})

We investigated a range of model types for M^{prop} , including Random Forest (RF), Bagged Support Vector Regressor (BSVR), Bagged Neural Network (BNN), and Bagged Ordinary Least Squares (BOLS). We used bagged versions of all but the RF models (RF is already an ensemble model) as these ensembles were used to generate uncertainty estimates and define the model M^{unc} . Note that M^{dis} depends only on the features of ITB data, X_{ITB} , and does not depend on the form of M^{prop} or M^{unc} . Two types of errors on property predictions were considered. First, absolute residuals $(|y - \hat{y}|)$, normalized by the Mean Absolute Deviation of y (MAD_y) was measured with Eq. 1 and was named $E^{|y-\hat{y}|/MAD_y}$.

$$E^{|y-\hat{y}|/MAD_y} = \frac{|y-\hat{y}|}{MAD_y} \tag{1}$$

Second, we denote the Root Mean Squared Error (RMSE) of predictions from M^{prop} normalized by the standard deviation of $y(\sigma_y)$ by the symbol E^{RMSE/σ_y} (see Eq. 2). In both Eqs. 1 and 2, "E" denotes that it is a type of error, \hat{y} is a prediction from M^{prop} , and \bar{y} is the mean of y. $E^{|y-\hat{y}|/MAD_y}$ can be measured for any individual data point considered, but can be randomly low for a data point known to be OD (i.e., residuals are stochastic). E^{RMSE/σ_y} considers residuals for groups of data, so data points with low and high values of $E^{|y-\hat{y}|/MAD_y}$ are included in a statistical measure. Both $A^{|y-\hat{y}|/MAD_y}$ and E^{RMSE/σ_y} were used in producing ID/OD labels to train M^{dom} (see Sec. 2.3).

$$E^{RMSE/\sigma_y} = \frac{RMSE}{\sigma_y} = \sqrt{\frac{\sum_{i=1}^{N} (y_i - \hat{y}_i)^2}{\sum_{i=1}^{N} (y_i - \bar{y})^2}}$$
(2)

2.2.2 Model for Uncertainty Estimates (M^{unc})

Uncertainty calibration has been extensively studied in both classification and regression settings [24–28]. Our study utilized uncertainty estimates for regression and used the calibration implementation from Palmer et al. [29]. In this approach, we started from an ensemble model to acquire individual predictions from each sub-model comprising an ensemble. The mean of predictions from the sub-models is \hat{y} . The standard deviation of predictions, σ_u , was calculated and then calibrated to yield the calibrated uncertainty estimates, denoted as σ_c . Repeated 5-fold CV was used throughout the study for producing residual and σ_u values used for calibration.

We borrowed arguments from Ref. [30] for assessing the quality of calibrated uncertainty estimates. The mean and variance of a set of z-scores, Z, should be 0 (unbiased) and 1 (unit-scaled), respectively. Each $z \in Z$ was calculated by $z = (y - \hat{y})/\sigma_c$. We made the assumption that the distribution of Z is standard normal (i.e., had a mean of 0 and a standard deviation of 1) for reliable uncertainty estimates as done in Refs. [31] and [29], which is not done in Ref [30]. We called the cumulative distribution of both Z and the standard normal distribution O(z) and $\Phi(0, 1)$, respectively. We calculated how far any O(z) was from $\Phi(0, 1)$ via Eq. 3, where E^{area} is the miscalibration area or error in uncertainties. Other measures of the quality of uncertainty measures exist like sharpness, dispersion, etc. (see Ref. [32]) that could be used instead. However, we used Eq. 3 because it includes information of σ_c , y, and \hat{y} . E^{area} was important for determining the quality of uncertainties in future sections and was used to produce ID/ODlabels for training M^{dom} (see Sec. 2.3).

$$E^{area} = \int_{-\infty}^{\infty} |O(z) - \Phi(0, 1)| dz \tag{3}$$

 E^{area} is a comparison of two statistical quantities and is inaccurate for small sample sizes. However, the comparison is still possible. If the sample size of $O(z)=\Phi(0,1)$ is 1, then the cumulative distribution will be 0 until the single observation and then become 1. E^{area} will be non-zero in the aforementioned case, but does not represent the population of O(z) well. In other words, even a single value sampled from a standard normal distribution will give a non-zero E^{area} . To prevent issues with small samples sizes, we performed multiple splits and binned data as outlined in Sec. 2.4.2 to get many points for statistical comparisons.

2.2.3 Model for Dissimilarity Measures (M^{dis})

KDE is a method to approximate a density of points given finite sampling of points from that density. If KDE is fit to a density distribution normalized to an area of one over a region, then KDE can be used to estimate the probability density (often called a likelihood) of observing points from the distribution at a point in that region. KDE works by first placing a local distribution (kernel) with a thickness (bandwidth) on each observed data point. Overlapping regions of kernels are superimposed, providing an estimate of an overall density and can be generalized to any number of dimensions [33]. In our approach, we developed a KDE of X_{ITB} whose values approximately give the likelihood of finding a data point at any coordinate in feature space.

To implement KDE, we took the following steps. First, X_{ITB} was standardized using scikitlearn's StandardScaler fit (i.e., data were rescaled to have a mean of zero and a standard deviation of one for each feature) [21]. This was done because the KDE implementation in scikit-learn uses a single bandwidth parameter, so all dimensions of X_{ITB} should be set to a similar length scale. Then, that single bandwidth parameter was used with the Epanechnikov kernel to construct the KDE of X_{ITB} data of M^{prop} . The bandwidth was estimated automatically using a nearest-neighbors algorithm as implemented in scikit-learn through the sklearn.cluster.estimate bandwidth method [21]. One could potentially obtain better results by more carefully optimizing the bandwidth for each data set and model combination studied. However, we opted for a straightforward automated approach to avoid any possible data leakage into our assessment and to keep the method simple to understand and implement. We used the Epanechnikov kernel because it is widely used and is a bounded kernel with a value of zero for any observation outside the bandwidth. This means that the likelihood of far away data will be exactly zero. Other kernels like the Gaussian and exponential kernels are unbounded and have non-zero values for any point. More details for these hyperparameter choices are covered in the Supplemental Materials.

Scikit-learn uses the natural logarithm of likelihoods as the inference outputs of KDE. We converted any logarithmic output to likelihoods by exponentiating the values. Eq. 4 was then employed to transform the likelihood of any inference data point \vec{x} with respect to the maximum likelihood observed from X_{ITB} . The result obtained from Eq. 4 served as our dissimilarity measure, d. It is important to note that \vec{x} was transformed using the same scaler utilized to build the KDE previously mentioned prior to attaining its likelihood with KDE(\vec{x}).

$$d = 1 - \frac{KDE(\vec{x})}{\max_{\forall \vec{a} \in X_{ITB}} (KDE(\vec{a}))}$$
(4)

This transformation did not alter the information provided by the KDE and was performed only to produce an easy to interpret number, which ranges from 0 to 1. A d value of 0 corresponds to \vec{x} being in the region of feature space most densely sampled by X_{ITB} (i.e., the peak of the KDE) and a d value of 1 corresponds to \vec{x} being far from X_{ITB} , where the density is zero for our choice of kernel.

2.2.4 Model for Domain (M^{dom})

 M^{dom} is a classifier which relies only on d as an input and produces $\widehat{ID}/\widehat{OD}$ given a cutoff, d^t . Values $d < d^t$ result in the label \widehat{ID} and values $d \ge d^t$ result in the label \widehat{OD} (Eq. 5). d^t is a value chosen from interval [0, 1]. Each d^t is associated with a specific set of $\widehat{ID}/\widehat{OD}$ predictions. The effectiveness for a given d^t is assessed by precision and recall given a ground truth, which we define based on chemistry, $E^{|y-\hat{y}|/MAD_y}$, E^{RMSE/σ_y} , or E^{area} (see Sec. 2.3 for ground truth labeling).

$$Predicted Label = \begin{cases} \widehat{ID}, & \text{if } d < d^t \\ \widehat{OD}, & \text{otherwise} \end{cases}$$
(5)

Here, we explain the procedure for training M^{dom} , which amounts to determining a single value called d_c^t . Note that M^{dom} can be trained with data from $E^{|y-\hat{y}|/MAD_y}$, E^{RMSE/σ_y} , E^{area} , or chemical information, and each will produce a different M^{dom} . Assume we have a data set split into ITB and OOB sets. We generated labels on OOB data for training M^{dom} by following the procedures outlined in Sec. 2.3, which produced the class labels of ID and OD. For each d^t , precision and recall were measured by comparing ID/OD and $\widehat{ID}/\widehat{OD}$ (Eq. 6). The number of True Positives (TP), True Negatives (TN), False Positives (FP), and False Negatives (FN) were acquired, corresponding to when the (ground truth, prediction) are $(ID, \widehat{ID}), (OD, \widehat{OD}), (OD, \widehat{ID})$, and (ID, \widehat{OD}) , respectively. Note that TN is not used in Eq. 6, but it is included for completeness.

$$precision = \frac{TP}{TP + FP}, \quad recall = \frac{TP}{TP + FN} \tag{6}$$

 M^{dom} learns by selecting d_c^t such that desirable properties are acquired. d_c^t can be selected to maximize the harmonic mean between precision and recall $(F1_{max})$ or to maximize recall while retaining a precision above a desired value. We used $F1_{max}$ for selecting d_c^t in this study unless explicitly stated otherwise. We performed many splits of data into ITB and OOB sets using the approaches described in Sec. 2.4.2 to obtain a large set of OOB data. We then find a single d_c^t to optimize F1 for all OOB data together. If all the OOB is OD, then d_c^t is set to less than zero (we effectively use $-\infty$) so that nothing is predicted \widehat{ID} . Conversely, d_c^t is set to greater than 1 (we effectively use $+\infty$) if all OOB data is ID so that all data are predicted \widehat{ID} . Each value of d was acquired from the KDE built from each X_{ITB} for each split.

Deployment of M^{dom} only relies on \vec{x} of a single data point and can produce $\widehat{ID}/\widehat{OD}$ for that point by checking the d produced by M^{dis} . If $d < d_c^t$, then the prediction is \widehat{ID} and \widehat{OD} otherwise (Eq. 5 when $d^t = d_c^t$). This describes how someone can use M^{dom} for domain prediction after training. Note that this prediction does not involve $E^{|y-\hat{y}|/MAD_y}$, E^{RMSE/σ_y} , E^{area} , nor chemical intuition after the learning process is complete. The overall precision and recall on splits used to find d_c^t can be stored and provided at inference along with $\widehat{ID}/\widehat{OD}$, giving guidance to the user on the confidence they should put in the domain determination.

2.2.5 Why not More Complex M^{dis} and M^{dom} ?

In this section, we discuss the question "Why use this particular approach to get domain when there are clearly opportunities for something potentially more accurate?" The composite function $M^{cdom} = M^{dom}(M^{dis}(\vec{x}))$ takes a feature vector for a given data point and returns a class value of $\widehat{ID}/\widehat{OD}$. In our approach, we used $M^{dis}(\vec{x})$ and a simple cutoff as the learned parameter for M^{dom} . One could easily replace this approach with a full ML model for M^{cdom} , presumably with much more ability to predict ID/OD. We did not do this for two reasons. First, we were concerned that it would be difficult to avoid overfitting a complex ML model for M^{cdom} with limited data. The present choice for M^{cdom} has almost no adjustable parameters and a strong foundation in our understanding that ML models learn best where there is more training data, which protects from overfitting. Second, we wanted to have a simple approach that was easy to use and reproduce by other researchers. We expect that more complex versions of M^{cdom} will be explored in the future, and we hope our work can provide a baseline for such studies, as our work has yielded a simple but promising method, as shown in Sec. 3.

2.3 Defining Ground Truths

In Sec. 1 we highlighted the absence of an absolute, unique definition for data being ID. As we are proposing M^{dom} to predict if a data point will be ID and wish to assess its effectiveness, we must provide some precise quantitative ground truth definitions for our OOB data points

being ID/OD. We will generally define a ground truth for an observation to be either ID or OD of a model based on privileged information, by which we mean information never seen during the creation of M^{prop} , M^{unc} , nor M^{dis} . Chemical differences, residuals, RMSEs, and accuracy of uncertainty estimates are examples of privileged information and are represented in our study by errors denoted as E^{chem} , $E^{|y-\hat{y}|/MAD_y}$, E^{RMSE/σ_y} , and E^{area} (defined in detail in Secs. 2.3.1, 2.2.1, and 2.2.2). Each of these errors has an associated cutoff to provide a ground truth ID/OD labeling. The cutoffs for E^{chem} , $E^{|y-\hat{y}|/MAD_y}$, E^{RMSE/σ_y} , and E^{area} are denoted E_c^{chem} , $E_c^{|y-\hat{y}|/MAD_y}$, E_c^{RMSE/σ_y} , and E_c^{area} , respectively. When $E^i < E_c^i$ ($i \in \{chem, |y - \hat{y}|/MAD_y, RMSE/\sigma_y, area\}$), the ground truth label is ID and OD otherwise (Eq. 7).

Ground Truth =
$$\begin{cases} ID, & \text{if } E^i < E_c^i \\ OD, & \text{otherwise} \end{cases}$$
(7)

We outline our rationale behind these sets of privileged information and how we used them to produce our ground truth labels in Secs. 2.3.1, 2.3.2, and 2.3.3. Figs. 1a through 1c illustrate the rationale for each set of privileged information, which are explained in each corresponding section. Note that there are multiple ways one could use different privileged information and define these ground truths, but we feel these form a logical and broad set of ground truths. The key result of this paper is to show that our dissimilarity measure d (see Sec. 2.2.3), determined only from the data features, can predict these ground truth ID/OD categorizations and therefore clearly contain essential aspects of this privileged information. We demonstrate this ability of d through the assessments outlined in Sec. 2.4.

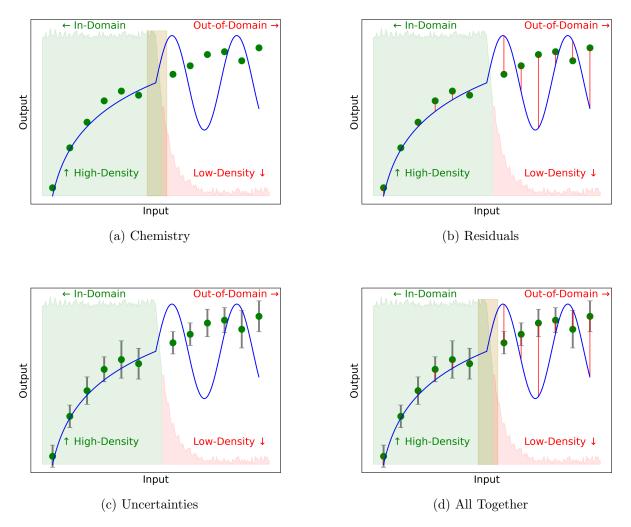


Figure 1: Conceptual illustrations of domain through various types of privileged information are shown. The ground truth data are represented by the blue line and is assumed to suddenly change its behavior from a square root type function to an oscillating sinusoidal type function at the boundary in the middle of each figure (Figs. 1a-1d). Examples of model inference are represented by green points. It is assumed that there is a large amount of training data (shown by the large amount of green area) in the region on the left side of each figure. It is also assumed that there is a small amount of training data (shown by the small amount of red area) in the region on the right side of each figure and decreases as one moves away from the boundary with the left side. Inference on data on the right side of each figure is OD, as illustrated by the clear change in the nature of underlying ground truth data, which might occur due to changes in chemistry in material applications (brown division in Fig. 1a), the large magnitude of residuals (red vertical lines in Fig. 1b), and the incorrect uncertainty estimates (gray error bars in Fig. 1c). Fig. 1d shows all these aspects together.

2.3.1 Chemical Intuition

We provide an abstract illustration of determining domains from chemical information in Fig. 1a. The true behavior of a physical relationship is shown by the blue line, while the estimates of the measure by M^{prop} are represented by the green dots. The green area depicts the region with ample amounts of ITB data and likely ID, while the red areas indicate regions with few ITB data and likely OD. Specialists have an intuition that the physical response changes between

ID and OD regions due to a physical change (e.g., phase transition), which is represented by the brown shaded region. M^{prop} fails to correctly predict the true behavior in the low-density (or OD) region of space, but an expert in materials science may have an intuition that the model would fail. The brown shaded region, in essence, represents the separation of materials that are ID from those that are OD via chemical intuition.

Here we define E^{chem} and associated cutoffs. We define E^{chem} as the mismatch between the chemistries used to build M^{prop} and those seen during deployment of M^{prop} . E_c^{chem} implicitly denotes when chemical mismatch (E^{chem}) becomes sufficiently large such that the physics governing materials defined as ID are vastly different from those that are OD. Both E^{chem} and E_c^{chem} depend on the set of studied materials, their governing physics, and empirical observations. By choosing very similar (e.g., materials selected from ITB data) and very different (e.g., materials with totally different composition, phases, controlling physics, etc.) materials, it is easy to produce data that are mostly ID/OD. For example, an M^{prop} trained on steel alloys (labeled ID) should not be applicable to polymers (labeled OD). Note that this approach does not require the value for the property being predicted, y. Therefore, we can assess M^{dom} on any data point for which we can write down the feature vector (\vec{x}) and have a useful intuition about its chemical similarity to ITB data. We view M^{dom} being successful at delineating ID/OD based on simple chemical intuition as a necessary, but not sufficient, condition to use KDE for domain determination. In other words, if M^{dom} struggles to delineate basic intuitive chemical domains, it is likely that the approach is not particularly useful for domain determination. Specifics on chemical groups, which implicitly define E_c^{chem} , are covered in Section 2.5.

2.3.2 Normalized Absolute Residuals and RMSE

We provide an abstract illustration for domain based on $E^{|y-\hat{y}|/MAD_y}$ and E^{RMSE/σ_y} in Fig. 1b. The green dots, blue line, and shaded regions have the same meaning as in Fig. 1a. As seen by the residuals (i.e., the red vertical lines) in Fig. 1b, the predictions of M^{prop} would, on average, have larger E^{RMSE/σ_y} for the entirety of an OD region compared to an ID region. However, individual measures of $E^{|y-\hat{y}|/MAD_y}$ can be randomly low for some data points in an OD region. The cutoffs based on residuals provide a bound for how poor predictions on a target property become before designating those predictions as OD.

Here we define the cutoffs $E_c^{|y-\hat{y}|/MAD_y}$ and E_c^{RMSE/σ_y} as the associated error metrics were already defined in Sec. 2.2.1. For an M^{prop} whose predictions represent the mean of all y (denoted as \bar{y}), both $E^{|y-\hat{y}|/MAD_y}$ and E^{RMSE/σ_y} are 1.0 as calculated from Eqs. 1 and 2. We consider this "predicting the mean" to be a baseline naïve model with respect to which any reasonable M^{prop} model should perform better. If a fit M^{prop} yields better predictions than a baseline, we considered those data to be ID, otherwise, those data were considered OD (Eq. 7). This defines $E_c^{|y-\hat{y}|/MAD_y} = E_c^{RMSE/\sigma_y} = 1$. Using either $E_c^{|y-\hat{y}|/MAD_y}$ or E_c^{RMSE/σ_y} as the ground truth cutoff for ID/OD labeling captures the widely invoked idea that ID cases should be predicted better compared to the OD cases. These definitions require residuals and can therefore be assessed on data with X and y for M^{prop} .

2.3.3 Errors in Predicted Uncertainties

Another abstract illustration for domain based on E^{area} is shown in Fig. 1c. The green dots, blue line, and shaded regions have the same meaning as in Figs. 1a and 1b. Each green dot in

the ID region has an uncertainty estimate from M^{unc} that includes the true behavior (blue) within its bounds. Conversely, the OD region has many uncertainties that may not include the true behavior within their bounds. The cutoff based on uncertainty estimate quality (i.e., E^{area}) separates regions where uncertainties are unreliable (i.e., OD regions) from other regions where uncertainties are more reliable (i.e., ID regions).

Here we define the cutoff E_c^{area} as the associated error metrics was already defined in Sec. 2.2.2. Similar to $E_c^{|y-\hat{y}|/MAD_y}$ and E_c^{RMSE/σ_y} in Sec. 2.3.2, we set E_c^{area} such that M^{unc} will show better performance than a naïve baseline case. For this case, we assume a baseline M^{prop} model that provides \bar{y} as the prediction for all cases and a baseline M^{unc} that provides the standard deviation of the training target values, σ_y , as the uncertainty for all cases. These baseline predictions can be used in Eq. 3 to measure E^{area} for any given set of data, and we take this predicted baseline E^{area} to be E_c^{area} . We defined *ID* cases as those for which the $E^{area} < E_c^{area}$ (*OD* otherwise). Unlike both $E^{|y-\hat{y}|/MAD_y}$ and E_c^{RMSE/σ_y} , E_c^{area} changes depending on the evaluated set of y and ranged from approximately 0.2 to 0.3 in our study. In other words, Eq. 3 does not yield a single number for naïve models.

It is worth relating that this criterion of $E^{area} < E_c^{area}$ for a set of data points tells us that M^{unc} is more accurate than the naïve baseline, but not that M^{prop} has small residuals. If M^{prop} has high E^{RMSE/σ_y} on a set of data points but M^{unc} has accurate estimates of those residuals, then M^{unc} clearly knows significant and useful information about the data, and the data is therefore in some sense ID. This situation can be contrasted with the case where M^{prop} has high residuals and M^{unc} has very inaccurate estimates of those residuals, in which case M^{prop} and M^{unc} appear to know nothing about the data, and the data is therefore reasonably considered OD. The extent a quality ID/OD ground truth definition can be defined by just E^{area} , whether E^{area} needs to be combined with the other errors considered, or even whether E^{area} should be excluded entirely from consideration, is not established at this point. Regardless, we show that M^{dom} provides an excellent ability to predict an ID/OD ground truth label based on E^{area} .

2.3.4 Summary of Ground Truth Definitions

The above detailed definitions of ID/OD can be confusing, so we summarize the idea again here. We considered four intuitive ways of thinking about being ID/OD of a trained model based on intuitive chemical similarity to ITB data, model residuals, model RMSEs, and model uncertainty estimates. For each way of thinking, we defined a score of the closeness of the data to being ID, which we denoted E^{chem} , $E^{|y-\hat{y}|/MAD_y}$, E^{RMSE/σ_y} , and E^{area} , respectively. We then used chemical intuition (for chemical dissimilarity) or naïve baseline model behavior (for model residuals and model uncertainty estimates) to define a cutoff (denoted E_c^i) for each corresponding E^i ($i \in \{chem, |y - \hat{y}|/MAD_y, RMSE/\sigma_y, area\}$) such that it was reasonable to assume that $E^i < E_c^i$ meant data were ID (Eq. 7). This allowed us to assign the labels of ID/OD for data so that we could evaluate the utility of d. It is important to realize that these ground truth definitions make extensive use of privileged information (i.e., information not expected to be available during application of the model). However, these ground truth definitions make no direct use of d and d makes no use of the privileged information. The value of our results is that we gain access to ID/OD measures that require privileged information by using d.

We note that while E^{chem} relies on a researcher's intuition regarding the chemical field and is specific to given fields, definitions relying on $E^{|y-\hat{y}|/MAD_y}$, E^{RMSE/σ_y} , and E^{area} are automated numerical approaches and quite general. Therefore, the success of M^{dom} on methods relying on $E^{|y-\hat{y}|/MAD_y}$, E^{RMSE/σ_y} , and E^{area} suggests our approach is not limited to materials and chemistry problems, but that in general d gives valuable access to the domain implications of knowledge of residuals. Note that the way we define E^{RMSE/σ_y} and E^{area} for our automated numerical ground truths require averaging over some groupings, which, as discussed in Sec. 2.4.2, are done based on d. Thus, there is a very modest and indirect path by which the nature of d can influence the ground truth categorization based on E^{RMSE/σ_y} and E^{area} . Although we think this effect is modest, it represents a path of data leakage that could potentially lead to bias in the assessments of the approach. To counteract this concern, we have included $E^{|y-\hat{y}|/MAD_y}$, which does not require any binning and is immune to data leakage. This quantity has other limitations (see Sec. 2.2.1), as it is quite stochastic, but our demonstrated success on assessments using the ground truth categorization from $E^{|y-\hat{y}|/MAD_y}$ and $E_c^{|y-\hat{y}|/MAD_y}$ demonstrates that the other successes were not dominantly influenced by data leakage from binning on d. In the next section, we outline assessments for each definition of ground truth.

2.4 Model Assessments

Now that we have defined ground truths in Sec. 2.3, we can assess how well M^{dom} , or equivalently, categorizing the data based on d (Eq. 5), can predict ID/OD. Specifically, we evaluate the ability of d obtained from M^{dis} to predict domain labels by building precision-recall curves on OOB data sets. For each precision-recall curve, a naïve baseline area under the curve (AUC) was constructed by considering a baseline model that predicts ID for every case, which yields a baseline AUC of the ratio of ID cases over the total number of cases [34]. The difference between the true and baseline AUC was used as an assessment metric, which we call AUC-Baseline. AUC was calculated using the sklearn metrics average precision score from scikit-learn [21]. AUC-Baseline shows how much additional information d provided for domain classification above the naïve baseline model. Any AUC-Baseline above zero indicates domain information retained by d. The values of precision, recall, and F1 were reported for the acquired metric of $F1_{max}$, which evaluates how effectively the ID points were separated from the OD points by the dissimilarity measure d. Note that assessment of how well d can predict ID/OD was conducted on OOB from nested CV, so data leakage was avoided.

2.4.1 Assessing Our Domain Prediction Based on A Ground Truth Determined by Chemical Intuition

In this section, we describe our method to evaluate how d provides information with respect to E^{chem} and call this assessment A^{chem} . We started with a set of ITB data that were used to construct M^{prop} and additional data with chemically distinct groups. These data are called the Original and non-Original sets, respectively. The non-Original set can be further subdivided into other chemistries and was always treated as OOB. Each case was labeled as ID/OD based on chemical intuition. We wanted to evaluate the ability of d to discern ID/OD from groups of chemistries that are OOB. To do this, we built sets of OOB data that contained ID/OD labels. For every observation in the Original set, i, the following sets of steps were performed: i was taken out of the Original set (i.e., placed in the OOB data), an M^{dis} model was trained on the remaining Original ITB data, then M^{dis} was used to calculate d on all OOB data (i.e., i and all cases from the non-Original set). This formed one prediction set. We repeated the procedure for all data points in the Original set and aggregated that data. In other words, we performed Leave-One-Out (LOO) CV on the Original set while treating the non-Original set as an OOB set for every iteration. If there are n cases from the Original set, then there should be n different

models and prediction sets by the time the procedure finished. See Fig. 2 for a diagram of the splitting procedure. Violin plots were generated to show the distribution of d values for each chemical group.

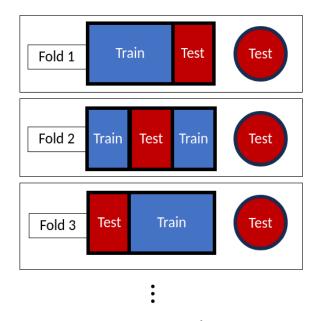


Figure 2: Shown is the splitting methodology for A^{chem} . The square and circle sets are from LOO CV and a fixed OOB set, respectively.

This methodology often produced a large class imbalance between the number of ID and OD cases, which can make interpreting the assessment of the domain classifier difficult. Therefore, we used a resampling procedure to obtain a balanced number of ID and OD data points in the OOB aggregated set. More specifically, if the number of ID cases exceeded the number of OD cases, we randomly sampled a subset of the ID data such that the number of ID cases was equal to the number of OD cases. Conversely, if the number of OD cases surpassed the number of ID cases, we randomly sampled a subset of the OD data to match the number of ID cases. However, if the ID and OD data sets contained an equal number of cases, no subsampling was performed. These samplings of data were then used to assess the ability of d to predict ID/OD with precision and recall.

2.4.2 Assessing Our Domain Prediction Based on A Ground Truth Determined by Normalized Residuals and Errors in Predicted Uncertainties

In this section we describe our method to evaluate how d provides information with respect to $E^{|y-\hat{y}|/MAD_y}$, E^{RMSE/σ_y} , and E^{area} and call these assessments $A^{|y-\hat{y}|/MAD_y}$, A^{RMSE/σ_y} and A^{area} , respectively. We must generate a set of OOB data that contain ID/OD labels to assess the ability of d to separate ID/OD. To do this, data containing both X and y were split using several methods for CV. First, data were split by 5-fold CV where models were iteratively fit on 4 folds and then predicted \hat{y} , σ_c , and d on OOB data. Second, data were pre-clustered using agglomerative clustering from scikit-learn [21]. One cluster was left out for OOB data, and all other ITB clusters were used to train models. Then, models predicted \hat{y} , σ_c , and d on the OOB data. Like the 5-fold CV methodology, we sequentially left out each cluster, which was similar to the approaches applied in Refs. [35, 36]. However, applying this clustering to the original data gave only a limited number of clusters. To generate many more OOB data,

we generated a series of bootstrap data sets from clusters and then applied the same leave out cluster approach. To clarify, we first clustered the data, and then performed bootstrapping separately on each cluster, rather than bootstrapping on all the data and then clustering. We call this a Bootstrapped Leave-One-Cluster Out (BLOCO) approach. We performed BLOCO with 3 and 2 total clusters with the aim of providing a large amount of OOB data that are increasingly dissimilar to ITB data and hopefully *OD*. See Fig. 3 for an illustration of BLOCO.

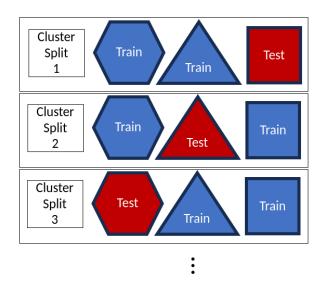
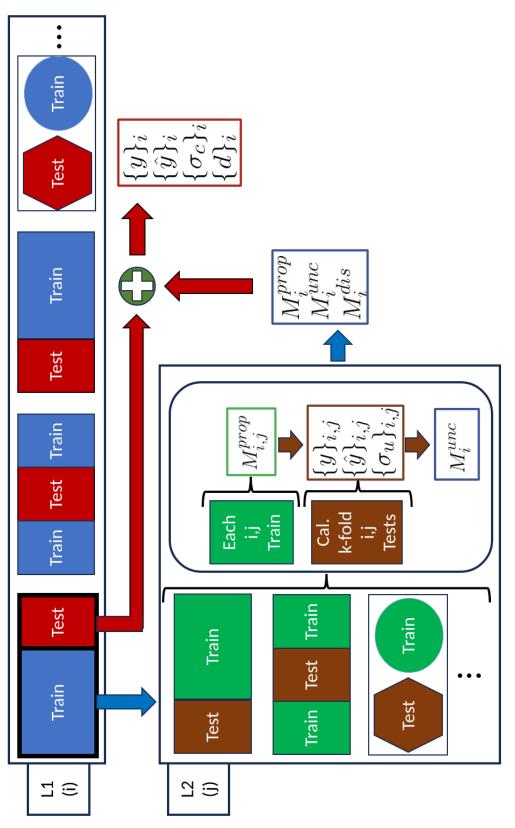


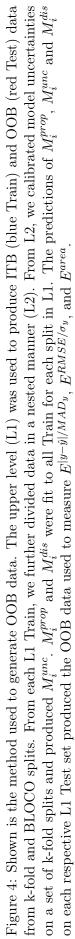
Figure 3: Shown is the BLOCO splitting methodology. Each shape represents a specific cluster. Clusters were iteratively swapped between ITB and OOB sets.

Both 5-fold CV and the BLOCO splitting strategies were repeated 5 times for nested CV on most data and model combinations. The workflow for producing the OOB data is shown in Fig. 4. Only BNN models had the number of repeats decreased to 3, 3, and 2 for the Fluence, Friedman, and Superconductor data sets, respectively. The amount of RAM consumed by BNNs for these larger data sets lead to a practical limitation on acquirable statistics. OOB data were aggregated and binned with respect to d into N bins with equal (or close to equal) number of points. If data could not be divided evenly (e.g., many repeated points with d=1), then the extra points went to the bin with the highest average d. Our choice of N = 10 gave robust results. The number of bins should strike a balance between being small enough for each bin to encompass a substantial number of data points for reliable statistics, yet large enough to effectively discern shifts in trends across different bins of OOB data. E^{RMSE/σ_y} was calculated for all OOB data in each bin. We subsequently compared O(z) to $\Phi(0,1)$ for each bin using Eq. 3, which provided E^{area} for each bin. The measure of $E^{|y-\hat{y}|/MAD_y}$ did not require binning and was measured for each individual data point. Note that normalization of $E^{|y-\hat{y}|/MAD_y}$ and E^{RMSE/σ_y} used the MAD_y and σ_y , respectively, from ITB data, not the OOB data. To avoid data leakage, we prevented models from learning on OOB data by incorporating information solely from ITB data during the model development phase, which may yield slightly different values for MAD_y and σ_y according to the splits considered. Class labels were acquired, $E^{|y-\hat{y}|/MAD_y}$ versus d plots were generated, $E^{RMS\dot{E}/\sigma_y}$ versus d plots were generated, E^{area} versus d plots were generated, and precision and recall scores were recorded. Each M^{dom} for $E^{|y-\hat{y}|/MAD_y}$, E^{RMSE/σ_y} , and E^{area} were built similarly. Any M^{dom} model checks the value of M^{dis} and returns a corresponding ID/OD value.

Unfortunately, the above steps meant that the choice of N impacted which data points were averaged together and therefore impacted the values of E^{RMSE/σ_y} and E^{area} and the grid of

points on which d can be evaluated. Thus, N impacts both this assessment of M^{dom} and the M^{dom} that would be developed for a model to be used at inference. While we have found that using 10 bins can be effective, it is important to note that this choice may not necessarily be optimal for these or general models. Future work should establish an approach for this binning that automatically selects N to obtain optimal results, or avoids binning altogether in the determination of d_c^t for M^{dom} . Note that $E^{|y-\hat{y}|/MAD_y}$ is unaffected by N.





2.5 Data Curation

We applied all previous definitions of domain and assessments with five data sets consisting of four physical data sets from the field of materials science and one synthetic data set (all discussed in detail below). Among these, the four physical property data sets exhibit welldefined chemical domains, with samples that are readily categorized as ID/OD. For three of the physical data sets, the data curation process involved generation of features, followed by a careful down-selection of a relevant X that held significance for y (see Supplemental Materials for the feature learning curves). It is important to remember that certain groups were denoted as Original and Perturbed Original across various data sets. It is essential to interpret these labels within the specific context of the material data set under investigation.

2.5.1 Diffusion Data Set

Diffusion activation energies (y) of single atom (dilute solute) impurities in metal hosts were acquired from Refs. [37, 38]. The activation energies were calculated using Density Functional Theory (DFT) methods. The total number of host-impurity pairs are 408. We refer to these compositions as the Original set. We generated host and impurity combinations across many chemical groups in the periodic table, but made sure to only include compositions outside the Original data set (no y are available). Chemical groups were assigned ID/OD based on intuition (Table 2). The Original group was labeled ID because they were data used to build M^{prop} models. Host metals for the Original group include elements in the following groups: alkaline earth, transition, and post-transition metals. Any data from the aforementioned groups that were not included in the Original data are considered to be ID due to their chemical proximity and shared physical properties. None of the remaining chemical groups in Table 2 were included as the host element in our data, and are therefore considered to be OD. Furthermore, we included a Manual group which mixed elements across chemical groups designated as [host][impurity] and are as follows: [Fe][O], [Fe][Cl], [Na][Cl], [Al][Br], [Ca][P], and [Sr][I]. This provided another OD group to test our d measure against. Mixing elements across the periodic table groups created a set of data with distinct physics compared to our *ID* data.

Table 2: Tabulated are the chemical domain labels for A^{chem}	i for the Diffusion data set.
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Chemical Group	Domain
Original	ID
Alkaline earth metals	ID
Transition metals	ID
Post-transition metals	ID
Metalloids	OD
Alkali metals	OD
Reactive nonmetals	OD
Noble gases	OD
Lanthanides	OD
Actinides	OD
Manual	OD

Features were generated using the MAST-ML elemental property feature generator (named ElementalFeatureGenerator in the package) [20]. The resulting features consist of the composition average, arithmetic average, maximum, and minimum values of elemental features for the host and impurities. While the DFT calculations used to create this database investigated dilute solutes in a metallic host, the host and impurity elements were weighted equally, following previous work in Refs. [37, 38]. The EnsembleModelFeatureSelector from MAST-ML was used to reduce the number of features to 25 (X) for the data containing y. We select the same X for data without y. The X we study has a strong relation with the y of interest. We do not concern ourselves with possible overfitting from feature selection on all the data as our aim is not to make a maximally robust model but to study how well we can predict the domain of the model. We refer to data in this section as "Diffusion".

2.5.2 Fluence Data Set

Data of Reactor Pressure Vessel (RPV) steel embrittlement were acquired from Ref. [39] and described in detail from the work in Ref. [40], where the ductile-to-brittle transition temperature shift, DT41J [C], is y. The total number of cases is 2,049. These steels are over 96.5 wt% Fe with small amounts of alloving additions less than around 3.5 wt%. For materials that should be ID, each element from each material of the Original set was incremented by ± 0.01 and then normalized such that the sum of element fractions is 1. These data have X that were slightly perturbed from the Original set and are called Perturbed Original. For OD data, a subset of materials without y from Ref. [41] were added (Table 3). These are randomly chosen metal alloys that have been previously manufactured, but contain a majority of either Al, Cu, or Fe. These data should be OD since much of the data contain elements not present in the Original set and contain less Fe in all cases except one. The exception has the element Be, which is not in our Original set. For these data, elemental feature generation was not needed and thus not conducted. Instead, the features for the Fluence data include the weight percentages of elements in each alloy (Fe, Cr, Al, Be, Co, Si, Mn, Zn, Sn, Pb, Ni, P, Cu, Mg, and C). Additional features include irradiation fluence (in log values), flux (in log values), and temperature for a total of 18 features used for A^{chem} . Note that this feature set is a natural extension of the successfully used features in Ref. [40]. For cases that do not provide irradiation fluence or flux, we performed mean imputation. For $A^{|y-\hat{y}|/MAD_y}$, A^{RMSE/σ_y} , and A^{area} , only the features that are chemically relevant for the Original set were used. Features of elemental weights for elements not seen in the Original set were dropped since the feature columns would be equal to zero for all data points. We also omitted the weight percent of Fe because it trivially represented the residual weight percent in the alloy composition. In other words, the weight percentages for Cu, Ni, Mn, P, Si, and C were kept with fluence, flux, and temperature, which constitute 9 features. We refer to data in this section as "Fluence".

Chemical Group	Material	Domain
Original	Many	ID
Perturbed Original	Many	ID
Copper-Based	Cu98.05Be1.7Co0.25	OD
Copper-Based	Cu85Zn15	OD
Copper-Based	Cu 89.8 Sn 10 P 0.2	OD
Copper-Based	Cu92Ni4Sn4	OD
Copper-Based	Cu85Zn5Pb5Sn5	OD
Aluminum-Based	Al95Si5	OD
Aluminum-Based	Al90Mg10	OD
Aluminum-Based	Al92.5Mg1.5Ni2Cu4	OD
Aluminum-Based	Al 83.5 Si 12 Mg 1 Ni 2.5 Cu 1	OD
Aluminum-Based	Al88Cu3.5Si8.5	OD
Iron-Based-Far	Fe99.1C0.2Mn0.45Si0.25	OD
Iron-Based-Far	Fe96.49C0.21Mn0.75Si0.25Ni2.3	OD
Iron-Based-Far	Fe60.6Ni35Si2C2.4	OD
Iron-Based-Far	Fe42.45 Cr 18 Ni 39 C0.55	OD
Iron-Based-Far	Fe63Cr28Ni9	OD

Table 3: Tabulated are the chemical domain labels for A^{chem} for both the Fluence and Steel Strength data.

2.5.3 Steel Strength Data Set

Data of steel strengths were acquired from Ref. [42] and our y is yield strength. The total number of cases is 312. These alloys are majority Fe with the minimum (maximum) percent of Fe being 62% (86%). The minimum (maximum) number of alloying components is 10 (13). Similar to our Fluence data, we create an ID set of cases by following the same elemental perturbation method. The same cases of OD materials from Table 3 were used as OD. The OD alloys either have majority Cu, Fe, or Al, or, if they have majority Fe, then the Fe percent is generally outside the range of our Original data (i.e., either Fe alloying percent is less or greater than the Fe percent in Ref. [42]). Furthermore, the minimum number of alloying components of 10 for ID alloys is much greater than the maximum of 5 for OD alloys. Similar to our study of the Diffusion data set, we used MAST-ML to generate elemental features [20]. However, we have the percent composition of constituent elements, so we included the weighted averages of properties based on elemental fractions. Application of the same feature selection method as used on the Diffusion data yielded 15 final features (X). We refer to data in this section as "Steel Strength".

2.5.4 Superconductor Data Set

Material compositions and superconducting critical temperatures were acquired from Ref. [43] and totaled 6,253 cases. Our y was the maximum temperature at which a material is capable of superconduction, T_C . We split our data into three sets for A^{chem} according to Ref. [43]. These sets are cuprates (called Cuprates), materials containing Fe (called Iron-Based), and materials left out by the previous two classifications (called Low- T_c). Stanev et al. have demonstrated that M^{prop} models trained exclusively on one of the aforementioned material classes cannot accurately predict T_C for the others. We compared d from M^{dis} on models trained only on subsets of each aforementioned material class and how it compared to the other two. As an

example, consider Cuprates. We perform A^{chem} treating Cuprates as ID, Iron-Based as OD and Low- T_c as OD (Table 4). Features were generated and selected similar to our Steel Strength data which yielded 25 features (X). We refer to data in this section as "Superconductor".

 $\begin{tabular}{|c|c|c|c|c|} \hline Chemical Group & ID & OD \\ \hline Cuprates & Cuprates & Iron-Based, Low-T_c \\ Iron-Based & Iron-Based & Cuprates, Low-T_c \\ Low-T_c & Low-T_c & Iron-Based, Cuprates \\ \hline \end{tabular}$

Table 4: Tabulated are the chemical domain labels for A^{chem} for the Superconductor data.

2.5.5 Friedman Data Set

Most data considered in our study are from the physical sciences. To test the generalizability of our developed methods and assessments, we also study a synthetic data set constructed from Eq. 8.

$$y = 10sin(\pi x_1 x_2) + 20(x_3 - 0.5)^2 + 10x_4 + 5x_5$$
(8)

Eq. 8 is a Friedman function from Ref. [44]. Each x_i is the feature for the dimension *i*. Like the original Friedman data set, each x_i was generated from a uniform distribution on the [0.0, 1.0) interval to generate y. We chose 500 samples. Because we wanted distinct domains to exist in our data, we also uniformly generated 500 points for each x_i from the following intervals: [0.0, 0.2), [0.2, 0.4), [0.4, 0.6), [0.6, 0.8), and [0.8, 1.0). Data generated from these intervals do not overlap, effectively creating distinct subspaces. For example, a sample where $x_1 = 0.1$ and $x_2 = 0.4$ cannot exist. We call these data Friedman. Additionally, we generated 3,000 points on the [0.0, 1.0) interval to explain one of our failure modes discussed in Sec. 3.5. We call these data Friedman WithOut Distinct Clusters (FWODC). Note that FWODC is only used in the context of explaining when our method fails. No feature selection was performed because the 5 features completely explain y.

3 Results and Discussion

Now that the conceptual tools and methodology used in this study are established, we can apply those concepts to various data sets and models. We start in Sec. 3.1 with A^{chem} and show that d mostly separated OD materials from ID materials. Although the separation is not perfect in many cases, it provided a clear way to flag OD materials. We then cover more automated numerical methods which do not require a priori knowledge of domains from chemical intuition. We show in Sec. 3.2 that d can be used to separate cases with high $E^{|y-\hat{y}|/MAD_y}$ (i.e., data that are OD) and cases with lower $E^{|y-\hat{y}|/MAD_y}$ (i.e., data that are ID). A similar observation was made in Secs. 3.3 and 3.4 except with the separation of high and lower E^{RMSE/σ_y} and E^{area} groups of data, respectively. We end with Sec. 3.5 by providing notes of caution for use cases where developed methods may not yield desired behavior.

3.1 Relationship Between Chemical Dissimilarity (E^{chem}) and Distance (d) from the Chemical Assessment (A^{chem})

For all chemical data sets analyzed through A^{chem} , violin plots for d with respect to chemical groups were generated and shown in Fig. 5. A positive result shows that ID materials have lower values of d compared to OD materials. Values to the left are more likely to be observed (i.e., be ID), and values to the right become less likely to be observed (i.e., be OD). All sets of A^{chem} generally show the aforementioned trend. Data are organized based on their median d values, with lower values positioned at the bottom and higher values at the top in Fig. 5. The precision and recall score metrics are tabulated in Table 5. Our $F1_{max}$ scores range from 0.71 to 1.00, which are rather high. We show how d is useful for flagging OD materials from predictions in subsequent text. The figures for all precision and recall curves are provided in the Supplemental Materials.

Table 5: Precision and recall data are tabulated for A^{chem} . The d_c^t , precision, recall, and F1 are for $F1_{max}$.

Data	Baseline	AUC	AUC-Baseline	d_c^t	Precision	Recall	F1
Diffusion	0.5	0.68	0.18	1.00	0.64	0.80	0.71
Fluence	0.5	1.00	0.50	0.99	1.00	1.00	1.00
Steel Strength	0.5	0.99	0.49	1.00	1.00	0.98	0.99
Cuprates	0.5	0.97	0.47	0.99	0.94	0.98	0.96
Iron-Based	0.5	0.84	0.34	0.97	0.58	0.98	0.73
Low- T_c	0.5	0.96	0.46	0.80	0.98	0.80	0.88

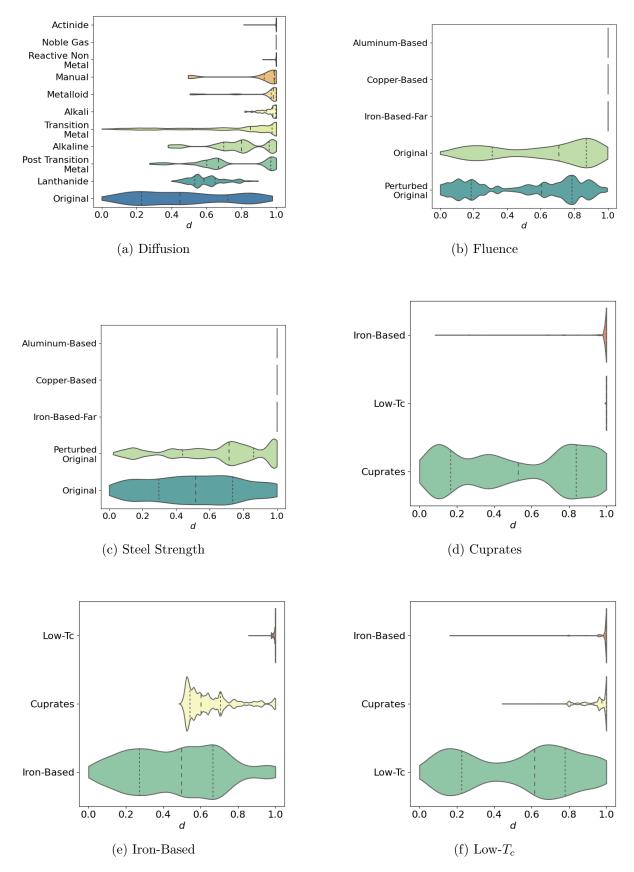


Figure 5: We show the violin plot for all the d scores separated by chemical groups. The first, second, and third vertical lines within each violin denote the separations between the first, second, third, and fourth quartiles. Values to the left are more likely to be observed compared to values to the right. All violins were forced to have the same width for visual purposes (i.e., the actual number of observations are not reflected by the visual).

The violin plot for the Diffusion data is shown in Fig. 5a. Intuitively dissimilar materials to the Original data subset, such as noble gases, are to the very right of the figure. Materials that were mixed across chemical groups (Manual set) also show high dissimilarities compared to the Original set. Conversely, more similar materials like transition metals, alkaline earths, and post transition metals have their median d value closer to the Original subset compared to the aforementioned groups. Lanthanides, however, appear closer to our Original set than expected. If we want 95% of data to come from a trustworthy chemical domain while maximizing recall for the Diffusion data, then the corresponding threshold of $d_c^t=0.45$ can act as a decision boundary. Using this threshold for M^{dom} , chemical groups such as noble gases, actinides, reactive nonmetals, etc. are mostly excluded from \widehat{ID} , but our recall is only 0.20. At a value slightly below 1.00 for d_c^t , our F1 score is maximized and can still exclude most noble gases, reactive nonmetals, and actinides. At $F1_{max}$, our recall and precision are 0.80 and 0.64 respectively. One can increase the precision of predictions by choosing a lower value of d_c^t at the cost of recall and vice versa according to the needs of M^{dom} application.

We have a similar observation for our Fluence data (Fig. 5b). Note that the Perturbed Original set have their quartiles shifted to the left of the Original data, meaning that values from the Perturbed Original data are predicted by the KDE to be more likely to be observed than test cases from the Original data, which is surprising. This is likely just an anomaly due to the modest size of the data and is not a concern given that both sets of data are *ID*. The important consideration is that all *OD* data have *d* values at or near 1.00. All *OD* data are far away from *ID* data. Any prediction with $d_c^t \approx 0.99$ is deemed to be untrustworthy and separates *ID/OD* essentially perfectly.

As for our Strength data in Fig. 5c, the Perturbed Original data have a median d value further to the right than the Original set, as expected. Most Perturbed Original data from the Strength data are to the left of other OD groups. In other words, OD data are further away than IDdata. The Iron-Based-Far data have cases that are closer to the Original data than the Copper-Based and Aluminum-Based sets, although it is not evident from the figure. The observation is reasonable considering most of the Original data are iron based, but outside the range of Feweight percentages in the Iron-Based-Far data. Like our Fluence data, any prediction at or near $d_c^t \approx 1.00$ was deemed to be untrustworthy. But unlike Fluence, ID/OD labels were not separated perfectly. Our recall is 0.98 because of a few FN predictions and the precision is 1.00.

Regarding the Superconductor data as described in Sec. 2.5.4, we divide data into Cuprates, Iron-Based, and Low- T_c groups and assess the behavior where each set was taken as the Original data (see Sec. 2.4.1) with the results shown in Figs. 5d, 5e, and 5f, respectively. In all cases, the ID materials in the Original data generally have d values to the left of OD data. $F1_{max}$ scores are not lower than 0.7, which is generally good. Note that we can tune d_c^t (i.e., non- $F1_{max} d_c^t$) such that the corresponding precision is near or at 1.00 at the cost of a lower recall for these data.

While our method does not flawlessly differentiate all chemical cases, it serves as a robust tool to eliminate a substantial portion of unreliable predictions. Furthermore, our chemical domains, like all the domain definitions in this paper, are approximate, and it is not expected that any method will provide perfect ID/OD predictions. Predicting domain with d_c^t derived from data analysis like those shown in Figs. 5a through 5f required being able to label a large set of data as chemically similar (ID) or dissimilar (OD), which requires extensive domain expertise and is not always feasible. Our other methods for domain determination rely purely on statistics of the trained model for assigning labels for domain, which makes them more practical for deployment. A^{chem} serves as an initial, intuitive, and rudimentary assessment, and passing this assessment was necessary for any domain method to be considered useful for materials. These

results show that d effectively provided privileged information regarding the chemical classes and physics that separate materials. We are confident that any positive outcomes observed for $A^{|y-\hat{y}|/MAD_y}$ (Sec. 3.2), A^{RMSE/σ_y} (Sec. 3.3), or A^{area} (Sec. 3.4) are not solely attributable to numerical artifacts. These readily interpretable results from A^{chem} establish a firm, intuitive, and chemically informed foundation before exploring more general numerical approaches, which we do now.

3.2 Relationship Between Absolute Residuals $(E^{|y-\hat{y}|/MAD_y})$ and Distance (d) from the Residual Assessment $(A^{|y-\hat{y}|/MAD_y})$

In Fig. 6, we illustrate how $E^{|y-\hat{y}|/MAD_y}$ is related to d for the RF model type. The same set of plots for other model types are offered in the Supplemental Materials, but we summarize their results in Table 6. We observe that $E^{|y-\hat{y}|/MAD_y}$ increases when the likelihood of observing similar points to ITB data decreases (larger d). All AUC-Baseline scores in Table 6 are positive, meaning that our d measure gives more information than a naïve guess provided by the baseline. Nearly all $F1_{max}$ scores are above 0.7, which means that d can be used to significantly separate ID and OD points. Only 2 out of 20 measures of $F1_{max}$ fall below 0.7. As an example of application, we can examine Fig. 6a and select $d_c^t=1.00$ for which we reject predictions (i.e., label as \widehat{OD}) from any M^{prop} according to Eq. 5. Most points with large $E^{|y-\hat{y}|/MAD_y}$ tend to occur at d=1.00. By selecting a $d_c^t=1.00$, a user can filter out the majority of those points from a study, thereby saving time by excluding untrustworthy cases. Other data sets in Figs. 6b, 6c, and 6d have more OD cases above $E_c^{|y-\hat{y}|/MAD_y}$ at lower d compared to the previous example. However, the fraction of OD cases greatly exceeds that of ID cases when d=1.00 and the fraction of ID cases is higher than the number of OD cases when d < 1.00. Therefore, the F_{1max} occurs at $d_c^t = 1.00$, where data have a zero likelihood based on the KDE constructed from ITB data. A similar methodology can be applied for d_c^t values across other data set and model combinations. Essentially, we can select predictions likely to be better than naïve as defined in Sec. 2.3.2. We note that $E^{|y-\hat{y}|/MAD_y}$ is a statistical quantity that will almost certainly be challenging to predict by d or any other domain method as it is quite stochastic. Even if one has a method that was essentially perfect at identifying data that was ID/OD, some residuals would likely be large for ID data and small for OD data by chance. Given this intrinsic limitation of predicting $E^{|\tilde{y}-\hat{y}|/MAD_y}$, we consider the present results quite strong. The statistical quantity $E^{\hat{R}MSE/\sigma_y}$ is essentially the same information as $E^{|y-\hat{y}|/MAD_y}$, but averaged over many points and therefore less stochastic, and we will see below that E^{RMSE/σ_y} is predicted more robustly by d.

Data	Model	Baseline	AUC	AUC-Baseline	d_c^t	Precision	Recall	F1
Friedman	RF	0.73	0.95	0.22	1.00	0.93	0.86	0.89
Friedman	BOLS	0.75	0.96	0.21	1.00	0.94	0.89	0.91
Friedman	BSVR	0.64	0.98	0.34	1.00	0.99	0.91	0.95
Friedman	BNN	0.71	0.97	0.27	1.00	0.98	0.89	0.93
Fluence	\mathbf{RF}	0.74	0.90	0.16	1.00	0.74	1.00	0.85
Fluence	BOLS	0.71	0.86	0.15	1.00	0.71	1.00	0.83
Fluence	BSVR	0.63	0.86	0.23	1.00	0.80	0.82	0.81
Fluence	BNN	0.65	0.92	0.26	1.00	0.88	0.91	0.89
Diffusion	\mathbf{RF}	0.57	0.95	0.38	1.00	0.96	0.89	0.92
Diffusion	BOLS	0.59	0.93	0.34	0.99	0.95	0.83	0.88
Diffusion	BSVR	0.48	0.96	0.48	1.00	0.88	0.98	0.93
Diffusion	BNN	0.53	0.90	0.37	1.00	0.85	0.86	0.86
Steel Strength	\mathbf{RF}	0.64	0.83	0.19	1.00	0.64	1.00	0.78
Steel Strength	BOLS	0.45	0.69	0.25	1.00	0.62	0.87	0.72
Steel Strength	BSVR	0.49	0.62	0.13	1.00	0.49	1.00	0.66
Steel Strength	BNN	0.49	0.68	0.19	1.00	0.64	0.80	0.71
Superconductor	\mathbf{RF}	0.62	0.79	0.17	1.00	0.62	1.00	0.77
Superconductor	BOLS	0.43	0.61	0.19	0.99	0.61	0.68	0.65
Superconductor	BSVR	0.62	0.70	0.08	1.00	0.62	1.00	0.77
Superconductor	BNN	0.57	0.74	0.18	1.00	0.57	1.00	0.72

Table 6: Precision and recall data are tabulated for $A^{|y-\hat{y}|/MAD_y}$. The d_c^t , precision, recall, and F1 are for $F1_{max}$.

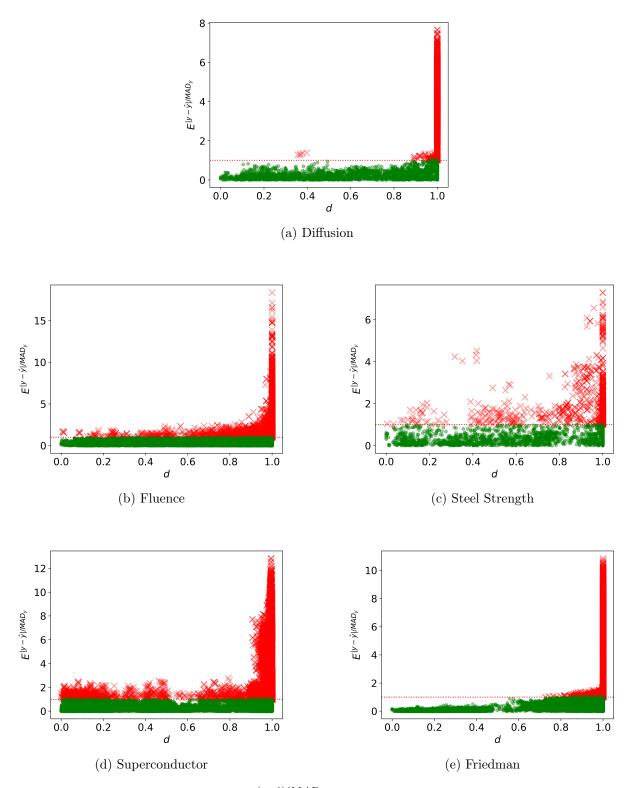


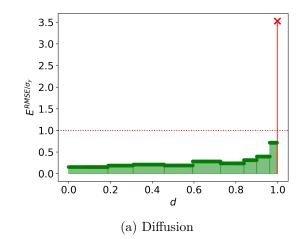
Figure 6: The relationship between $E^{|y-\hat{y}|/MAD_y}$ and d for the RF model type is shown. Generally, $E^{|y-\hat{y}|/MAD_y}$ increases with an increase in d. $E_c^{|y-\hat{y}|/MAD_y}$ is shown by the horizontal red line, which separates our OD (red) and ID (green) cases.

3.3 Relationship Between RMSE (E^{RMSE/σ_y}) and Distance (d) from the RMSE Assessment (A^{RMSE/σ_y})

In Fig. 7, we illustrate how E^{RMSE/σ_y} is related to d for the RF model type. The same set of plots for other model types are offered in the Supplemental Materials, but we summarize their results in Table 7. Similar to the results in Sec. 3.2, we observed that E^{RMSE/σ_y} increased when the likelihood of observing similar points to ITB data decreased (larger d). All AUC-Baseline scores in Table 7 are positive, meaning that our d measure gives more information than a naïve guess provided by the baseline. Nearly all $F1_{max}$ scores are 1.00, which means that ID and OD bins were nearly perfectly separated (i.e., only 4 out of 20 were not perfect but still above 0.7). As an example of application, we can examine Fig. 7c and select $d_c^t=0.85$ for Eq. 5. Three bins at d>0.85 have E^{RMSE/σ_y} above E_c^{RMSE/σ_y} and are OD. All other bins have E^{RMSE/σ_y} below E_c^{RMSE/σ_y} and are ID. If M^{dis} yields d=0.95 for a data point, the point falls in a bin that is OD. A similar methodology can be applied for d_c^t values across other data set and model combinations. We can use d to distinguish points where E^{RMSE/σ_y} is expected to be low from those likely to have high E^{RMSE/σ_y} (i.e., we can discern predictions likely to be better than a naïve as defined in Sec. 2.3.2).

Table 7: Precision and recall data are tabulated for A^{RMSE/σ_y} . The d_c^t , precision, recall, and F1 are for $F1_{max}$.

Data	Model	Baseline	AUC	AUC-Baseline	d_c^t	Precision	Recall	F1
Friedman	RF	0.67	1.00	0.33	1.00	1.00	1.00	1.00
Friedman	BOLS	0.71	1.00	0.29	1.00	1.00	1.00	1.00
Friedman	BSVR	0.62	1.00	0.38	1.00	1.00	1.00	1.00
Friedman	BNN	0.65	1.00	0.35	1.00	1.00	1.00	1.00
Fluence	\mathbf{RF}	0.64	1.00	0.36	1.00	1.00	1.00	1.00
Fluence	BOLS	0.57	0.99	0.41	1.00	0.89	1.00	0.94
Fluence	BSVR	0.43	1.00	0.57	0.91	1.00	1.00	1.00
Fluence	BNN	0.64	1.00	0.36	1.00	1.00	1.00	1.00
Diffusion	\mathbf{RF}	0.53	1.00	0.47	1.00	1.00	1.00	1.00
Diffusion	BOLS	0.53	1.00	0.47	1.00	1.00	1.00	1.00
Diffusion	BSVR	0.53	1.00	0.47	1.00	1.00	1.00	1.00
Diffusion	BNN	0.47	1.00	0.53	0.96	1.00	1.00	1.00
Steel Strength	\mathbf{RF}	0.47	1.00	0.53	0.85	1.00	1.00	1.00
Steel Strength	BOLS	0.36	0.96	0.61	0.78	0.83	1.00	0.91
Steel Strength	BSVR	0.20	1.00	0.80	0.43	1.00	1.00	1.00
Steel Strength	BNN	0.47	1.00	0.53	0.88	1.00	1.00	1.00
Superconductor	\mathbf{RF}	0.45	0.78	0.34	0.93	1.00	0.61	0.76
Superconductor	BOLS	0.36	1.00	0.64	0.97	1.00	1.00	1.00
Superconductor	BSVR	0.54	0.85	0.31	0.97	1.00	0.67	0.80
Superconductor	BNN	0.36	1.00	0.64	0.97	1.00	1.00	1.00



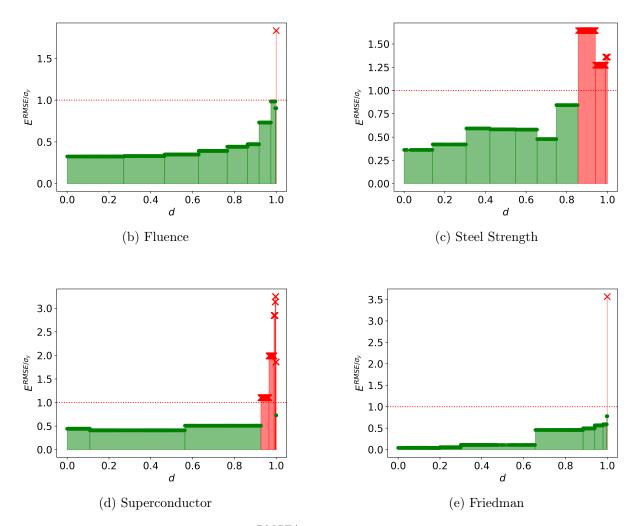


Figure 7: The relationship between E^{RMSE/σ_y} and d for the RF model type is shown. Generally, E^{RMSE/σ_y} increases with an increase in d. E_c^{RMSE/σ_y} is shown by the horizontal red line, which separates our OD (red) and ID (green) bins.

3.4 Relationship Between Miscalibration Area (E^{area}) and Distance (d) from the Uncertainty Quality Assessment (A^{area})

We now provide a similar analysis for E^{area} as provided for E^{RMSE/σ_y} in Sec 3.3. In Fig. 8, we illustrate how E^{area} and d are related for the RF model type. The same set of plots for the other model types are offered in the Supplemental Materials, but we summarize their results in Table 8. We observed that E^{area} for bins with small d values tend to be relatively small compared to bins with larger d values for all the data presented in Fig. 8. All AUC-Baseline scores are greater than zero except for two, indicating that two data set and model combinations performed worse than naively predicting the number of *ID* bins (i.e., only 2 out of 20 results were undesirable). For the most part, our d measure offers substantial insight into the quality of E^{area} for the reported data. Approximately half (9 out of 20) of the model type and data combinations yield precision and recall scores of 1.00, indicating their ability to perfectly discern points in ID/ODbins. A total of 11 out of the 20 entries report $F1_{max}$ above 0.7, which is relatively good but not nearly as great as the results from $A^{|y-\hat{y}|/MAD_y}$ and A^{RMSE/σ_y} . An additional 4 entries were only slightly below 0.7. The only entries with $F1_{max}$ scores worse than naïve were Steel Strength with BNN and Diffusion with BOLS. No data for the entry for Friedman with BOLS was ID, which was the reason for an AUC-Baseline of zero. The quality of M^{unc} affects the ability of M^{dom} to discern domain, a problem we discuss in detail as case (ii) in Sec. 3.5 and in the Supplemental Materials. As an example of application, we can examine Fig. 8b and select $d_c^t = 0.92$ for as a threshold to discern between ID/OD bins. If M^{dis} yields d=0.5 for a point, the point falls in a bin that is ID. If M^{dis} yields d=0.99 for a point, the point falls in a bin that is OD. Choices for d_c^t can be similarly made for other models. These results show that we can usually use d to distinguish points where E^{area} is expected to be low from those likely to have high E^{area} (i.e., we can discern predictions likely to be better than a naïve defined in Sec. 2.3.3). It is important to note that each bin utilizes the exact same data to calculate E^{RMSE/σ_y} and E^{area} . This implies that bins that were ID based on E_c^{RMSE/σ_y} but OD based on E_c^{area} had low absolute residuals but poor uncertainty quantification accompanying the predictions.

Data	Model	Baseline	AUC	AUC-Baseline	d_c^t	Precision	Recall	F1
Friedman	RF	0.29	1.00	0.71	0.65	1.00	1.0	1.00
Friedman	BOLS	0.00	0.00	0.00	$-\infty$	0.00	0.0	0.00
Friedman	BSVR	0.23	1.00	0.77	0.34	1.00	1.0	1.00
Friedman	BNN	0.21	0.30	0.09	0.98	0.43	1.0	0.60
Fluence	\mathbf{RF}	0.43	1.00	0.57	0.92	1.00	1.0	1.00
Fluence	BOLS	0.29	0.43	0.14	0.97	0.57	1.0	0.73
Fluence	BSVR	0.43	1.00	0.57	0.91	1.00	1.0	1.00
Fluence	BNN	0.43	1.00	0.57	0.92	1.00	1.0	1.00
Diffusion	\mathbf{RF}	0.18	1.00	0.82	0.46	1.00	1.0	1.00
Diffusion	BOLS	0.53	0.50	-0.03	1.00	0.53	1.0	0.69
Diffusion	BSVR	0.18	1.00	0.82	0.46	1.00	1.0	1.00
Diffusion	BNN	0.06	0.31	0.25	0.31	0.50	1.0	0.67
Steel Strength	\mathbf{RF}	0.33	1.00	0.67	0.65	1.00	1.0	1.00
Steel Strength	BOLS	0.14	0.29	0.15	0.78	0.33	1.0	0.50
Steel Strength	BSVR	0.07	0.31	0.24	0.30	0.50	1.0	0.67
Steel Strength	BNN	0.13	0.13	-0.01	0.99	0.22	1.0	0.36
Superconductor	\mathbf{RF}	0.27	1.00	0.73	0.93	1.00	1.0	1.00
Superconductor	BOLS	0.27	0.90	0.63	0.97	0.75	1.0	0.86
Superconductor	BSVR	0.09	0.31	0.22	0.56	0.50	1.0	0.67
Superconductor	BNN	0.18	0.32	0.14	0.99	0.40	1.0	0.57

Table 8: Precision and recall data are tabulated for A^{area} . The d_c^t , precision, recall, and F1 are for $F1_{max}$.

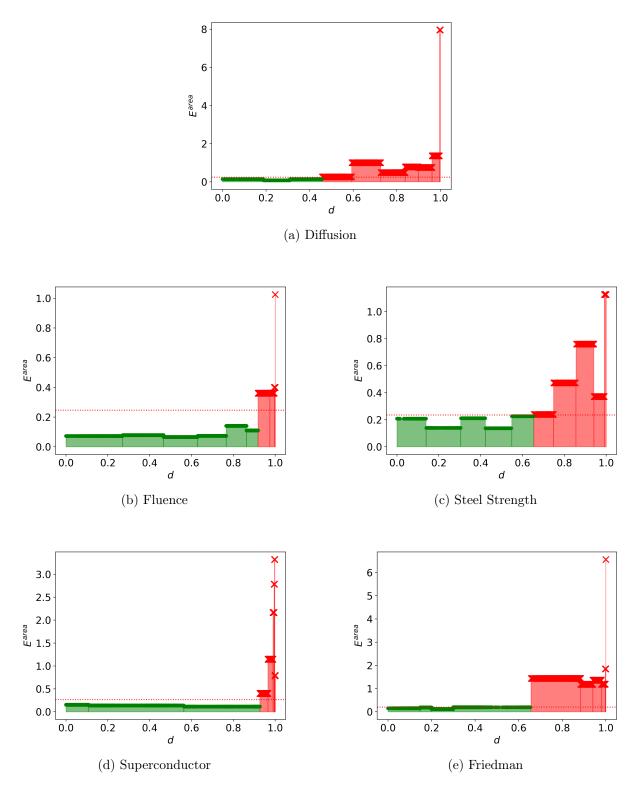


Figure 8: The relationship between E^{area} and d for the RF model type is shown. Generally, E^{area} increases with an increase in d. E_c^{area} is shown by the horizontal red line, which separates our OD (red) and ID (green) bins.

3.5 Notes of Caution for Domain Prediction

We have identified four scenarios that could, but not necessarily, lead to the breakdown of developed models (although others likely exist): (i) the trivial case where OOB y cannot be learned from X (M^{prop} breaks), (ii) the case where uncertainties are bad (M^{unc} breaks), (iii) the case where BLOCO fails to select regions of X that are sufficiently distinct as OOB sets, and (iv) the case where KDE does not provide adequate information about ITB data because of a very large number of features. We will show the first 3 failure modes with easily controlled data generated with Eq. 8 (Friedman and FWODC). To show case (i), we shuffled y with respect to X. M^{prop} could not learn y from X in this scenario. E^{RMSE/σ_y} will be above E_c^{RMSE/σ_y} for all (or nearly all) bins of d. To show case (ii), we used uncalibrated (σ_u) instead of calibrated (σ_c) uncertainties. If M^{unc} is not accurate, then d will show no reasonable trend between E^{area} and d. To show case (iii), we used UMAP to show how insufficient clustering of distinct spaces provided values of d that could not be used to build M^{dom} . This is a failure in producing ID/ODlabels for OOB data. In cases (i)-(iii), the failure is not really a problem with the fundamental domain method, as we now explain. For case (i), it is reasonable to assume an M^{prop} model has no domain (or, equivalently, all data is OD) if its predictions are poor, and therefore no domain prediction method can reasonably be expected to work. Similarly, an M^{unc} incapable of generating accurate uncertainties as outlined in case (ii) would have most, if not all, data as being OD. For case (iii), we do not separate data with our BLOCO procedure. This is not a failure of the fundamental approach, but a failure of our specific strategy for splitting leading to poor generation of ID/OD samples. However, case (iv) would be a true failure of the underlying KDE approach, although we have not seen it occur in our tests.

The RF model type was used for M^{prop} for cases (i)-(iii) with either Friedman or FWODC data. We start with case (i) using the Friedman data. By shuffling y with respect to X, the results from our assessments of A^{RMSE/σ_y} breakdown (Fig. 9). Note that all predictions from M^{prop} are worse than naively predicting \bar{y} for all points. A d_c^t cannot be established for separating ID/OD cases from E^{RMSE/σ_y} since all data are OD.

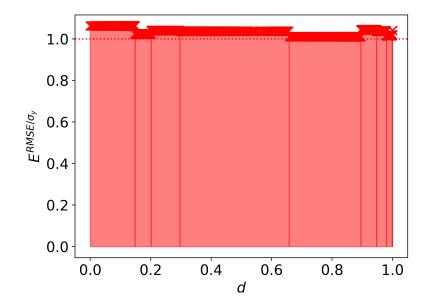


Figure 9: The assessment of the Friedman data fit with an RF model type is shown where we purposefully shuffled y to achieve an M^{prop} with no predictive ability. Because X no longer has a strong relationship with y, all data are OD.

Fig. 10 shows how M^{dom} fails if M^{unc} fails via case (ii). We use σ_u instead of σ_c as the estimates provided by M^{unc} . Errors in our uncertainties are high, and no value of d_c^t separates ID/ODpoints well (M^{dom} failure) because no bins exist that are ID. Note that the portion of M^{dom} trained with E^{RMSE/σ_y} data should remain unaffected as long as M^{prop} functions well.

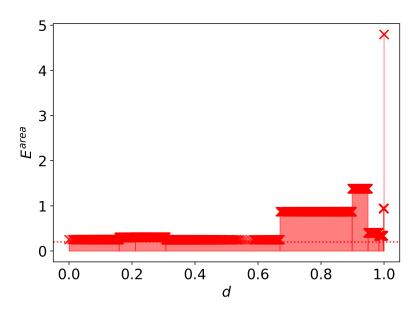


Figure 10: The relationship between d and E^{area} are shown for using σ_u instead of σ_c for M^{unc} . Because M^{unc} is poor at estimating uncertainties, all data are OD.

Failure case (iii) for our domain methodology stems from a specific failure case of the BLOCO procedure. First, we use the UMAP approach to project X into a two-dimensional space and visualize the cluster labels assigned by agglomerative clustering for Friedman (Fig. 11a) and FWODC (Fig. 11b) data. Each color from the figures represents the cluster labels. Because there are intervals of sampling for X that exclude other intervals as defined in Sec. 2.5.5 for Friedman in Fig. 11a, we can cluster subspaces of X that are distinct. If we consider FWODC as shown in Fig. 11b, all data that are OOB by BLOCO are close to each other, which results in an insufficient distinctiveness of clusters for pseudo-label generation (ID/OD).

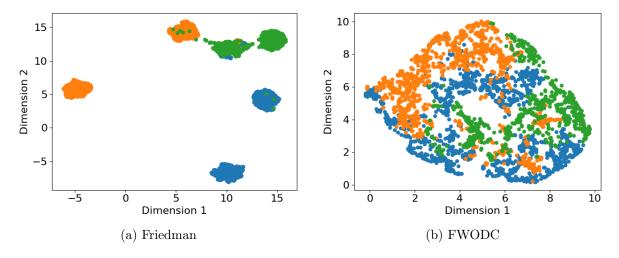


Figure 11: The UMAP projections of Friedman and FWODC onto two-dimensions are shown. One sampling of X yields distinct regions in features (left) and the other does not (right). The colors represent the labels for clusters acquired through agglomerative clustering.

The X space from Fig. 11a led to the previously seen results on A^{RMSE/σ_y} and A^{area} (Figs. 7e and 8e). Data used to make Fig. 11b led to the results shown in Fig. 12. For Fig. 12a, we know that data at d=1.00 can produce OD points as seen in Fig. 7e. For Fig. 12b, E^{area} is much larger for our first bin than that from Fig. 8e. Conversely, E^{area} is much smaller for our last bin in Fig. 12b compared to Fig. 8e. Unusual trends of d with respect to E^{area} emerge when the data set lacks diversity (i.e., data that cannot be clustered well).

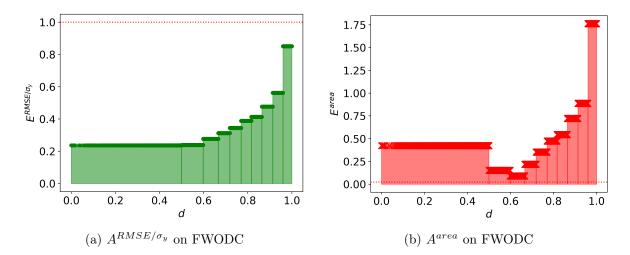


Figure 12: The relationship between d, E^{RMSE/σ_y} , and E^{area} are shown for the poorly clustered data. Note that at least the bin with the highest d for A^{RMSE/σ_y} should be OD. We observe that data closest to our X_{ITB} for A^{area} are marked as OD domain by E_c^{area} , but should ideally be ID.

Finally, we discuss failure mode (iv). We do not illustrate case (iv), as we did not run into this problem in our studies, but is worth mentioning. KDE is known to have challenges in getting accurate representations for a large number of dimensions [45]. For models with many features, it is possible that KDE will give a poor representation of the distance to the X_{ITB} data and the approach taken in this work will break down (i.e., yield inaccurate $\widehat{ID}/\widehat{OD}$ labels). We do not have any example of where this occurs but note the concern for completeness. Feature selection to obtain a modest feature number for which the KDE methods work is suggested. We do not know how many features may cause issues, but the models studied here use a maximum of 25 features.

In summary, there are three known conditions and a fourth one hypothesized that will lead to a non-functional M^{dom} . First, M^{prop} cannot properly predict y from X. Second, M^{unc} fails to provide accurate measures of uncertainty. Third, the data cannot be clustered to produce ID/OD labels. Fourth, the KDE fails to provide a good density due to a large number of features. So long as the aforementioned conditions are not met, M^{dom} has been found to effectively predict domain in our tests.

4 Conclusion

Our work addresses a significant concern in the deployment of machine learning models: the potential for these models to produce inaccurate or imprecise predictions without warning. We have shown that kernel density estimates provide valuable insights into where in the feature space model performance degrades significantly or where predictions fall outside the model's domain

of applicability. The central idea of our approach is to use kernel density estimation to define a dissimilarity measure d and then classify data as in-domain or out-of-domain based on d. We assessed the approach with a range of machine learning models (random forest, bagged neural network, bagged support vector regressor, and bagged ordinary least squares) on data sets with diverse physical properties and chemistries (dilute solute diffusion in metals, ductile-to-brittle transition temperature shifts in irradiated steel alloys, yield strengths of steel alloys, and superconducting critical temperatures) as well as the synthetic Friedman data set. We demonstrated qualitatively that as d increased, data became more chemically distinct, residual magnitudes increased, and uncertainty estimates deteriorated, validating that d was a powerful descriptor for these critical ways of thinking about domain. Our quantitative assessment compared our predicted domain categorization to ground truth values based on chemistry, residuals, and uncertainty estimates and generally found good improvement over naïve models and high F1 scores. This approach can be easily applied to many problems and allows categorization of in-domain or out-of-domain for any test data point during inference. The approach can be applied easily through its stand-alone implementation or its implementation in the MAterials Simulation Toolkit - Machine Learning (MAST-ML) package (see Data and Code Availability). Researchers can easily use this method to provide automated guardrails for their machine learning models, greatly enhancing their reliable application.

5 Data and Code Availability

The raw and processed data required to reproduce these findings are available to download from figshare at doi: 10.6084/m9.figshare.25898017. The developed code is available through GitHub at https://github.com/uw-cmg/materials_application_domain_machine_learning.git and is implemented in MAST-ML in https://github.com/uw-cmg/MAST-ML.git.

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Glossary

$A^{ y-\hat{y} /MAD_y}$	The assessment of d with respect to labels produced with $E_c^{ y-\hat{y} /MAD_y}$
A^{RMSE/σ_y}	The assessment of d with respect to labels produced with E_c^{RMSE/σ_y}
A^{area}	The assessment of d with respect to labels produced with E_c^{area}
A^{chem}	The assessment of d with respect to labels produced with E_c^{chem}
AI	Artificial Intelligence
AUC	Area Under the Curve
BLOCO	Bootstrapped Leave-One-Cluster Out
BNN	Bagged Neural Network
BOLS	Bagged Ordinary Least Squares
BSVR	Bagged Support Vector Regressor
Cuprates	The Cuprate subset of the Superconductor dataset described in Sec. 2.5.4
CV	Cross Validation
d	The KDE dissimilarity measure
d^t	A cutoff value in the interval $[0, 1]$ used by M^{dom} for class prediction
d_c^t	A selected value of d_c^t which gives $F1_{max}$
a_c DFT	Density Functional Theory
Diffusion	The Diffusion dataset described in Sec. 2.5.1
$E^{ y-\hat{y} /MAD_y}$	The absolute residuals normalized by MAD_y as defined by Eq. 1
E^{RMSE/σ_y}	The RMSE normalized by σ_y as defined by Eq. 2
E^{area}	The miscalibration area as defined by Eq. 3
E^{chem}	The chemical mismatch as defined in Sec. $2.3.1$
$E_c^{ y-\hat{y} /MAD_y}$	The ground truth label cutoff for $E^{ y-\hat{y} /MAD_y}$ using Eq. 7 in Sec. 2.3.2
E_c^{RMSE/σ_y}	The ground truth label cutoff for E^{RMSE/σ_y} using Eq. 7 in Sec. 2.3.2
E_c^{area}	The ground truth label cutoff for E^{area} using Eq. 7 in Sec. 2.3.3
E_c^{chem}	The ground truth label cutoff for E^{chem} using Eq. 7 in Sec. 2.3.1
F1	The harmonic mean between precision and recall scores
$F1_{max}$	The maximum $F1$
Fluence	The Fluence dataset described in Sec. 2.5.2
FN	False Negative
FP	False Positive
Friedman	The Friedman dataset described in Sec. 2.5.5
FWODC	Friedman WithOut Distinct Clusters

$ID \\ \widehat{ID} \\ ID/OD \\ \widehat{ID}/\widehat{OD} \\ Iron-Based \\ ITB$	Inside the Domain Predicted ID ID or $ODPredicted ID/ODThe Iron-Based subset of the Superconductor dataset de-scribed in Sec. 2.5.4In-The-Bag$
KDE	Kernel Density Estimate
LOO Low- T_c	Leave-One-Out The Low- T_c subset of the Superconductor dataset described in Sec. 2.5.4
M^{prop} M^{unc} M^{dis} M^{dom} M^{cdom} MAD_y MAST-ML ML	The model for property prediction The model for uncertainty prediction The model for measuring dissimilarity through KDE The model classifying $\widehat{ID}/\widehat{OD}$ The composite function $M^{dom}(M^{dis}(\vec{x}))$ The mean absolute deviation of y values Materials Simulation Toolkit for Machine Learning Machine Learning
NN	Neural Network
OD	Outside the Domain
$ \begin{array}{l} \widehat{OD} \\ OOB \\ O(z) \end{array} $ PDF	Predicted OD Out-Of-Bag The observed cumulative distribution of z values Probability Density Function
$ \begin{array}{c} \widehat{OD} \\ OOB \\ O(z) \end{array} $	Predicted OD Out-Of-Bag The observed cumulative distribution of z values
$ \begin{array}{l} \widehat{OD} \\ OOB \\ O(z) \end{array} $ PDF	 Predicted OD Out-Of-Bag The observed cumulative distribution of z values Probability Density Function The cumulative distribution of a standard normal distribution where the means is 0 and the standard deviation
$ \begin{aligned} \widehat{OD} \\ OOB \\ O(z) \\ PDF \\ \Phi(0, 1) \\ RF \\ RMSE \\ RMSE $	 Predicted <i>OD</i> Out-Of-Bag The observed cumulative distribution of z values Probability Density Function The cumulative distribution of a standard normal distribution where the means is 0 and the standard deviation is 1 by definition Random Forest Root Mean Squared Error
$ \begin{array}{l} \widehat{OD} \\ OOB \\ O(z) \\ PDF \\ \Phi(0,1) \\ \end{array} $ RF RMSE RPV $ \begin{array}{l} \sigma_c \\ \sigma_u \\ \sigma_y \\ \end{array} $ Steel Strength	 Predicted <i>OD</i> Out-Of-Bag The observed cumulative distribution of <i>z</i> values Probability Density Function The cumulative distribution of a standard normal distribution where the means is 0 and the standard deviation is 1 by definition Random Forest Root Mean Squared Error Reactor Pressure Vessel Calibrated uncertainty estimates The standard deviation of a set of <i>y</i> values The Steel Strength dataset described in Sec. 2.5.3

$egin{array}{c} X \ ec x \ X \ X_{ITB} \end{array}$	The features for a set of \vec{x} The feature values for a single case The X for ITB data
$egin{array}{c} y \ \hat{y} \ ar{y} \ ar{y} \end{array}$	The regression target The regression target The mean of a set of y values
$Z \\ z$	A set of z values Scaled uncertainties defined by $(y{\textbf -}\hat{y})/\sigma_c$